

# PHOTONICS Research

## Dual-band perfect absorber for a mid-infrared photodetector based on a dielectric metal metasurface

ZHAO CHEN,<sup>1,\*†</sup>  YUDONG WENG,<sup>1,†</sup> JUNKU LIU,<sup>1</sup> NAN GUO,<sup>1</sup> YAOLUN YU,<sup>1</sup> AND LIN XIAO<sup>1,2</sup>

<sup>1</sup>Nanophotonics and Optoelectronics Research Center, Qian Xuesen Laboratory of Space Technology, China Academy of Space Technology, Beijing 100094, China

<sup>2</sup>e-mail: xiaolin@qxslab.cn

\*Corresponding author: chenzhao@qxslab.cn

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Mid-infrared thermal detectors have very important applications in the aerospace and military fields. However, due to the low heat transfer efficiency and slow response time, their application has been greatly restricted. Here, we theoretically demonstrate a dual-band perfect absorber for a mid-infrared detector based on a dielectric metal metasurface, and the optical and thermal properties are analyzed in detail. Simulation results show that the two narrow absorption peaks, corresponding to the absorption value of 97.5% at  $\lambda = 6.142 \mu\text{m}$  with  $\lambda_{\text{FWHM}} \approx 40 \text{ nm}$  and 99.7% at  $\lambda = 7.795 \mu\text{m}$  with  $\lambda_{\text{FWHM}} \approx 80 \text{ nm}$ , respectively, are achieved, and their different dependences on the structural parameters have been studied. A thermal detector at room temperature with total response time within 1.3 ms for dual-band and 0.4 ms for single-band is realized when the incident light flux is  $1.0 \text{ W/cm}^2$  for an average temperature increase of  $\Delta T \approx 1.0 \text{ K}$ . Our study offers a promising approach for designing a narrowband mid-infrared perfect absorber and a high-performance photodetector in nano-integrated photonics. © 2020 Chinese Laser Press

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### 1. INTRODUCTION

Plasmonic metasurfaces, which can be designed and manipulated to obtain outstanding optical properties, e.g., extraordinary optical transmission (EOT) and perfect absorption, have drawn immense attention in recent years [1–8]. Numerous functional devices have been realized in such systems [9], including but not limit to sensors [10,11], polarizers [12–14], and perfect absorbers (PAs) [15–19]. Among them, PAs, especially mid-infrared PAs based on metasurfaces, have many applications in material analysis and spectral detection thanks to the associated strong light–matter interaction [15–19]. Metasurface PAs, which exhibit the ability to yield near-unity absorptivity in nearly any frequency range, were introduced by Landy *et al.* in 2008 [7], and were demonstrated experimentally by Liu *et al.* for the first time in 2010 [20]. According to Kirchhoff's law of thermal radiation, at equilibrium, the emissivity of a material equals its absorptivity. Therefore, PAs have been used for various optoelectronic applications, such as emitters [21], solar cells [22,23], and photodetectors [24–26].

Mid-infrared photodetectors at micro-nano scale are widely used in various fields such as military field, science, industry, agricultural production, and medical hygiene. Especially in the

military field, infrared photodetectors play an irreplaceable role in precision guidance, aiming systems, and night vision. At present, type-II superlattice and quantum dot detectors can achieve rapid response, yet they require low temperature and are relatively expensive [27–29]. The photodetectors based on the heterojunction of 2D materials have improved detection efficiency and response time, but these materials are difficult to prepare in large areas, and further research is needed for on-chip integration [30–32]. While detectors based on the hot carrier effect are limited by the Schottky barrier and the maximum wavelength of detection is limited to near infrared [33–35], PA-based thermal detectors do not have these limitations. The resonant absorber is used as the “heat source” of the thermal detector. Through clever design, perfect absorption of any wavelength can be realized [24–26,36–38]. Therefore, it is of great significance to combine the PA with the mid-infrared detector. Most of the PAs are built as “metal nanostructure”–insulator–metals (MIMs) [33–35]. However, in such systems, a part of the heat will be split by the “metal nanostructure,” which affects the heat transfer efficiency and increases the response time of the detector. Chen *et al.* [39] and Lan *et al.* [40] proposed a dielectric metasurface with a metal film substrate system to improve heat transfer efficiency and realize

surface-enhanced infrared sensing, respectively. Nevertheless, there are relatively little research on mid-infrared thermal detectors based on the PA of the dielectric microstructure and metal reflector system, especially research on dual-band mid-infrared thermal detectors.

In this paper, we reported dual-band mid-infrared PAs based on dielectric metal metasurfaces. We discuss in detail the influence of structural parameters on the absorption characteristics of the system based on the finite element method (FEM). We find that the two narrowband absorption peaks have different changing laws. In the meantime, we could control the presence or absence of the second absorption peak by adjusting the height of the dielectric grating. In addition, we analyze the application of this system in a mid-infrared photodetector by adding pyroelectric material, and the “metal dissipation” is directly used as the “heat source” of the thermal detector, which increases the heat transfer efficiency. When the incident flux is about  $1.0 \text{ W/cm}^2$ , the average surface temperature of the pyroelectric material increases  $1.0 \text{ K}$ , which only takes  $0.35 \text{ ms}$  for dual-band and  $0.1 \text{ ms}$  for single-band, which provides a reference for the experimental preparation of high-sensitivity infrared thermal detectors. The proposed structure is compact and will have important applications in nanophotonics and mid-infrared photodetection.

## 2. STRUCTURE AND SIMULATION RESULTS

The schematic diagram of our structure is proposed in Fig. 1(a), and the unit cell [inset in Fig. 1(b)] consists of a lossless silicon grating (with width  $w$  and height  $h$ ), a gold (Au) reflector (with fixed thickness  $\sim 50 \text{ nm}$ ), and temperature sensitive material aluminum nitride (AlN). Since the thickness of the Au reflector is greater than the skin depth of the surface plasmon, the

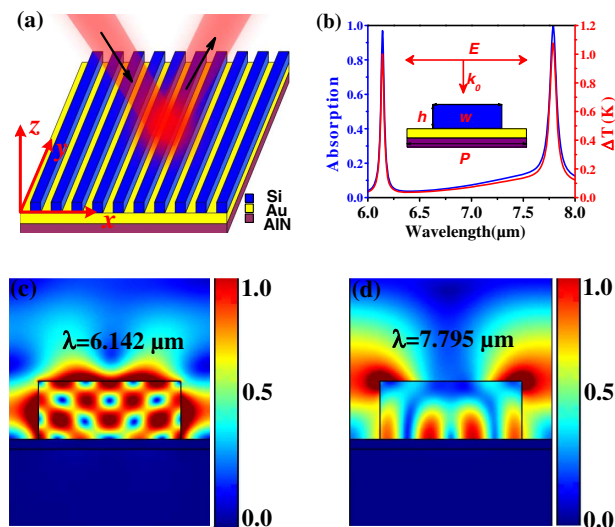
transmission coefficient of the system is zero, and the sensitive materials will not affect the optical properties of the system. The incident light is  $x$ -polarized and propagates along the  $z$  axis, dielectric guide mode resonance can be excited at the resonant wavelength, and the energy will be efficiently absorbed by the metal layer, yielding a peak in the absorption spectra [40]. The dissipative energy density is proportional to the resonant angular frequency  $\omega$  and the imaginary part  $\text{Im} \epsilon(\omega)$  of the dielectric function of the medium [41],

$$Q = \frac{1}{2} \epsilon_0 \omega \text{Im} \epsilon(\omega) |E|^2, \quad (1)$$

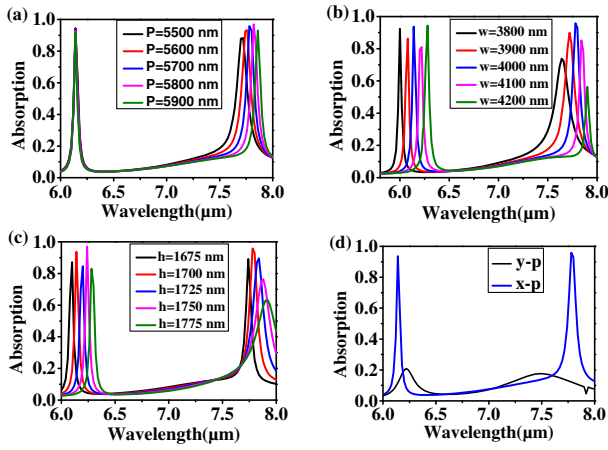
where  $\epsilon_0$  is the electric constant in vacuum. Thus, a PA at the resonance can be an efficient light to heat transducer.

Here, the absorption spectrum at normal incidence is investigated by the commercial software COMSOL Multiphysics 5.2a based on the FEM (see Appendix A for more details). The calculated absorption spectrum is shown in Fig. 1(b) (blue line) with  $P = 5700 \text{ nm}$ ,  $w = 4000 \text{ nm}$ , and  $h = 1700 \text{ nm}$ . Obviously, two absorption peaks with nearly unity absorption at the resonant wavelength of  $\lambda = 6.142 \mu\text{m}$  ( $A \approx 97.5\%$ ) and  $\lambda = 7.795 \mu\text{m}$  ( $A \approx 99.7\%$ ) are observed, which are caused by the inevitable plasmonic loss of gold. The full width at half-maximum (FWHM) of the two peaks is about  $40 \text{ nm}$  and  $80 \text{ nm}$  with high quality factor [42] of 153 and 85, respectively. To display the relationship between the two absorption peaks and structural parameters intuitively, the  $|E|$ -field distributions of the two resonant wavelengths are plotted in Figs. 1(c) and 1(d), respectively. From Fig. 1(c), we know that the  $|E|$ -field of the first absorption peak ( $\lambda = 6.142 \mu\text{m}$ ) is mainly concentrated around the Si-grating, that is to say, changes in the width and height of the Si-grating will affect the position of the peak significantly. From Fig. 1(d), it is clearly shown that one part of the  $|E|$ -field of the second absorption peak ( $\lambda = 7.795 \mu\text{m}$ ) is trapped inside the Si-grating strip, while another part is concentrated at the ends on the topside surface, which implies that the period and the grating parameters will markedly affect the position of the peak. The distinctly different magnetic field distributions further illustrate the different dependence of the two peaks. While absorption only occurs in the metal layer, their power loss patterns are almost the same (see Appendix B for more details). This kind of dual narrowband PA can be used to realize high level spectral selectivity, which has important applications in target recognition and chemical detection.

To test above analysis, the absorption characteristics of the system with different parameters are simulated by the FEM. Figure 2(a) shows the absorption spectra pertinent to different period  $P$  with  $w = 4000 \text{ nm}$  and  $h = 1700 \text{ nm}$ . It is clearly shown that the position of the first absorption peak does not change, while the position of the second absorption peak is approximately linearly ( $\Delta\lambda \approx 40 \text{ nm}/\Delta P = 100 \text{ nm}$ ) redshifted as  $P$  increases. Figures 2(b) and 2(c) display the change of the absorption spectra as the grating structure parameters (width  $w$  with  $P = 5700 \text{ nm}$  and  $h = 1700 \text{ nm}$ , or height  $h$  with  $P = 5700 \text{ nm}$  and  $w = 4000 \text{ nm}$ ) vary. It is easy to find that the first absorption peak has a linear redshift relationship with  $w$  or  $h$  increasing, and little change in the absorption coefficients, while the second absorption peak has a nonlinear redshift that corresponds to an increase in  $w$  or  $h$ , and the



**Fig. 1.** (a) Schematic of the resonant absorption structure based on dielectric-metal metasurface. (b) Theoretical absorption spectrum (blue line) and normalized average temperature increasing of the sensitive material upper surface,  $\Delta T$  (red line). Normalized  $|E|$ -field distributions for the two absorption peaks at (c)  $\lambda = 6.142 \mu\text{m}$  and (d)  $\lambda = 7.795 \mu\text{m}$ . Inset shows the unit cell of the structure and parameter symbols.



**Fig. 2.** Optical properties of the metastructure absorber. The graphs show the spectra of absorption with different (a) period  $P$ , (b) width  $w$ , (c) height  $h$ , and (d)  $E$ -polarization.

absorption coefficient changes significantly, especially for  $h$ , e.g., when  $h = 300$  nm, the second absorption peak disappears (see Appendix C for more details). These results are consistent with the above field distributions analysis. In addition to the influence of structural parameters on the absorption characteristics of the system, the proposed structure also has polarization-selective characteristics. Figure 2(d) exhibits the absorption spectrum for the system under  $y$  polarization (black line) and the  $x$ -polarized (blue line for comparison). It can be seen that our system has very good polarization selectivity, which will promote the system to have a wider range of applications than a polarization-independent system [39]. It is important to note that due to the relatively large refractive index of Si, it supports more cavity modes. Therefore, the proposed PA system is more sensitive to angular incidence (see Appendix D for more details).

The absorbed electromagnetic radiation is converted into heat through Joule heating (resistive heat) following the Poynting's theorem [43]. When our plasmonic absorber is under pulsed optical excitation, the temperature on the surface of the sensitive material will first rise and then fall. The heat transfer equation for our system reads

$$\rho c \frac{\partial \Delta T}{\partial t} - \vec{\nabla} \cdot (k \vec{\nabla} \Delta T) = Q_{\text{abs}}, \quad (2)$$

In this equation,  $\rho$ ,  $c$ , and  $k$  are the mass density, specific heat, and thermal conductivity, respectively. Local heat intensity  $Q_{\text{abs}}$  comes from the light dissipation in the Au reflector. Since Si is lossless, that is, only the Au reflector acts as the “heat source,” the efficiency of heat transfer to the heat-sensitive material can be improved. The increased temperature  $\Delta T = T - T_0$ , where  $T_0$  and  $T$  is the ambient temperature (293.15 K) and average temperature on the surface of sensitive materials after photoexcitation, respectively.

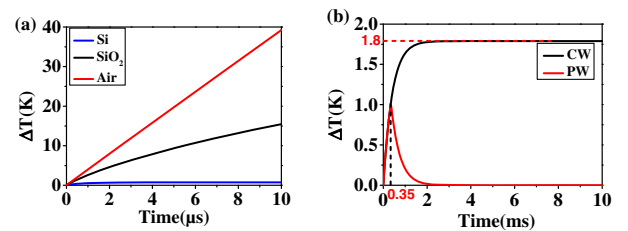
In the thermal simulation, we use AlN as the heat-sensitive material. All the relevant materials' thermal parameters used in the simulation are shown in Table 1. AlN, a kind of pyroelectric material, possesses a temperature-dependent spontaneous polarization and on heating its polarization is altered [44].

**Table 1.** Thermal Parameters of the Materials Used in Our Metastructures

Materials	$k$ [W/(m · K)]	$\rho$ [g/cm <sup>3</sup> ]	$c$ [J/(g · K)]
Si	131	2.239	0.7
Au	319	19.3	0.129
AlN	290	3.26	0.75
SiO <sub>2</sub>	1.38	2.196	0.703

AlN is well suited to ambient temperature operation when heated below its Curie temperature [45]. A current will be produced when the system is connected to an external circuit, due to the generation of pyroelectric voltage, which is caused by time-varying optical/thermal signals altering the density of the interfacial charges [44]. The red curve in Fig. 1(b) shows the normalized average increased temperature  $\Delta T$  on the upper surface of AlN with wavelength changing. It can be seen that the surface temperature difference  $\Delta T$  of the pyroelectric material AlN has a positive correlation with the absorption of the system; that is, the greater the absorption rate, the greater the  $\Delta T$  and vice versa.

In order to explore the application of this system in mid-infrared detectors, we take the first absorption peak,  $\lambda = 6.142$   $\mu\text{m}$  (the second absorption peak has a similar result), as an example ( $P = 4700$  nm,  $h = 1700$  nm,  $w = 4000$  nm) and investigate the temporal temperature distributions under different input conditions at this wavelength. First, we research the situation of different substrate materials, silicon (Si), silica (SiO<sub>2</sub>), and air, and the corresponding temporal temperature distributions are shown in Fig. 3(a) with the same incident flux  $I_0 = 10^3$  W/cm<sup>2</sup>. It can be clearly seen that when the substrate material is air (the system is suspended), the time required to rise to the same temperature is the shortest. In other words, the response of the suspended detector is the fastest, about 0.25  $\mu\text{s}/\text{K}$  due to the smaller thermal conductivity, mass density, and specific heat capacity of air. Making the system suspended in the air is an effective way to improve the sensitivity of the detector [46]. In addition to the rise time, the total response time of the detector also includes the fall time, which is the time required for the detector to return to the initial state when the “heat source” is removed. Thus, the temporal temperature distributions of the suspended system under continuous wave (CW) and pulsed wave (PW) illumination are considered at the same incident flux  $I_0 = 1.0$  W/cm<sup>2</sup> (see Appendix E for



**Fig. 3.** Temporal temperature distributions for (a) different substrate materials with the same incident flux  $I_0 = 10^3$  W/cm<sup>2</sup> and (b) continuous wave and pulsed wave illumination when the system is suspended with incident flux  $I_0 = 1.0$  W/cm<sup>2</sup>.

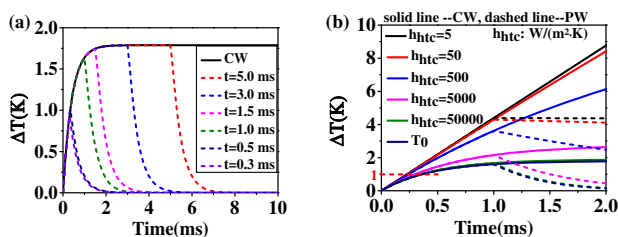


the situations of the other two materials). The pulse function has the following form:

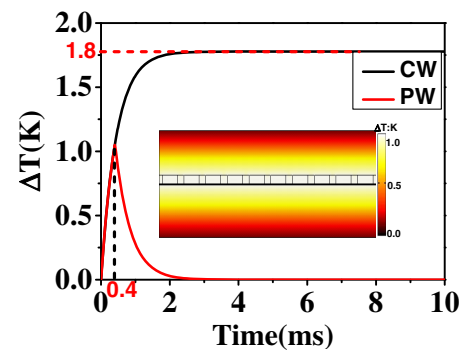
$$\text{pulse}(t) = \begin{cases} 1, & 0 < t \leq 0.35 \text{ ms} \\ 0, & \text{else} \end{cases} \quad (3)$$

When the pulse wave is incident, the Au-plate absorbs the light energy, and the temperature rises for  $0 < t \leq 0.35$  ms, and then, for  $t > 0.35$  ms, the temperature starts to drop back and finally returns to the initial state; the temporal temperature distributions are shown in Fig. 3(b) (red line). When the continuous wave is incident, the system has been absorbing the light energy, and the temperature has been rising until it reaches a steady state ( $\Delta T \approx 1.8$  K), as shown in Fig. 3(b) (black line). We take  $\Delta T = 1.0$  K as a reference; the system temperature rise time is about 0.35 ms, and the fall time is about 0.95 ms (down to below 10% of 1.0 K). Therefore, the total response time of the proposed detector is only about 1.3 ms. The fast response time for the proposed dielectric metal metasurface is mainly due to the high absorption coefficient and high heat conversion efficiency; while it has higher heat transfer efficiency than the traditional MIM structure system since the light wave energy is concentrated in the single-layer metal plate, avoiding the intermediate process of heat transfer [36–38]. In addition, reducing the volume of the bulk material will increase the sensitivity of the detector. When  $h = 300$  nm, the total response time of the detector at the absorption peak ( $\lambda = 6.155$   $\mu\text{m}$ ,  $A = 95.8\%$ ,  $I_0 = 1.0$   $\text{W}/\text{cm}^2$ ) is only about 0.4 ms (see Appendix C for more details). From Fig. 3, we can also find that for different incident flux, the rise time for  $\Delta T \approx 1.0$  K is different obviously. Hence, we compared the results in literature [44] with the same external conditions (the Si-substrate and 1 kHz, 100 fs laser at  $\lambda = 6.142$   $\mu\text{m}$  were used). Simulated results show that only 1.0 ps rise time was needed for  $\Delta T \approx 1.0$  K in our system (see Appendix F for more details), while 6.0 ps in Ref. [44]. The proposed structure provides the possibility for the practical application of mid-infrared rapid detection in the future.

Consecutively, the temporal temperature distributions for different pulse times  $t$  and heat transfer coefficients  $h_{\text{htc}}$  at  $t = 1.0$  ms are investigated when the system is suspended, as shown in Figs. 4(a) and 4(b), respectively. Here,  $h_{\text{htc}}$  represents the heat exchange capacity between the interface and the surrounding environment, and the higher the value is, the stronger the heat dissipation capacity is (see Appendix A for more details). One can see that as the pulse time increases,



**Fig. 4.** Temporal temperature distributions for different (a) pulse time  $t$  illumination and (b) heat transfer coefficients  $h_{\text{htc}}$  at  $t = 1.0$  ms when the system is suspended with incident flux  $I_0 = 1.0$   $\text{W}/\text{cm}^2$ .



**Fig. 5.** Temporal temperature distributions for 100 $\times$  unit cells with incident flux  $I_0 = 1.0$   $\text{W}/\text{cm}^2$  under CW and PW illumination. Inset shows the maps of temperature distributions at  $t = 0.4$  ms.

$\Delta T$  keeps increasing, and the time for the detector to return to its initial state increases accordingly, until the system reaches a steady state. At this time, the total response time of the detector depends on the recognition of the minimum value of  $\Delta T_{\text{min}}$  by the peripheral readout circuit. Different heat transfer coefficients  $h_{\text{htc}}$  will affect the total response time of the detector. From Fig. 4(b), a small  $h_{\text{htc}}$  will make the detector heat up quickly, and the cooling time (fall time) will be greatly increased. For example, when  $h_{\text{htc}} = 500$   $\text{W}/(\text{m}^2 \cdot \text{K})$ , the rise time is about 0.24 ms for  $\Delta T = 1.0$  K, while the fall time is about 6.26 ms. Therefore, the designed detector must have good heat dissipation capacity to reduce the total response time.

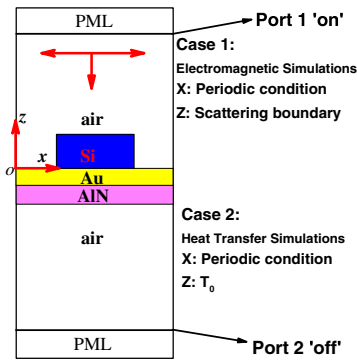
Finally, we extend the proposed structure to 100 $\times$  unit cells, and the open boundary conditions are applied to replace the period boundary conditions. The temporal temperature distributions under CW and PW illumination are shown in Fig. 5. The total rise time (0.4 ms) and fall time (1.2 ms) are slightly larger than those in Fig. 3(b). The inset of Fig. 5 shows the maps of temperature distributions at  $t = 0.4$  ms. The proposed structure is very compact and can be easily fabricated by electron beam lithography [47], which provides the potential possibility for the practical application in the near future.

### 3. CONCLUSION

In conclusion, we have demonstrated a dual-band PA for a mid-infrared photodetector based on a dielectric silicon metasurface, gold reflector, and pyroelectric material AlN. Simulation results show that the two narrowband perfect absorption peaks are achieved, and they can be easily tuned by controlling the structural parameters. In addition, the proposed system has good polarization selectivity, and the presence or absence of the second absorption peak can be controlled by altering the height of the Si-grating. The proposed system has higher heat conversion and heat transfer efficiency than traditional MIM structures. These physical features contribute to a fast total response time of about  $\sim 1.3$  ms for dual-band and  $\sim 0.4$  ms for single-band mid-infrared photodetectors at incident light flux  $1.0$   $\text{W}/\text{cm}^2$ . Our study provides direction and reference for the future design of high-sensitivity mid-infrared detectors.

### APPENDIX A: COMSOL MULTIPHYSICS 5.2A SIMULATIONS

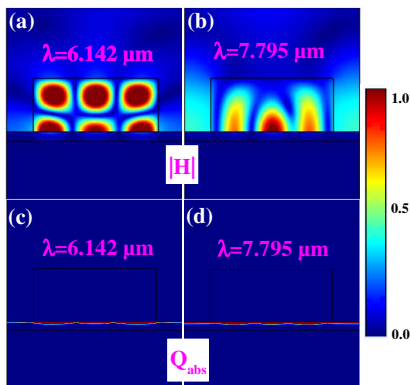
In order to reduce calculation memory and time, our proposed structure can be simplified to a 2D system, the Wave Optics module (frequency domain) coupled with Heat Transfer module by Electromagnetic Heat Source is used for the absorptive characteristics and thermal simulations. The boundary conditions are laid out in Fig. 6. The materials were directly imported from COMSOL material library, and the PML layers are about 20  $\mu\text{m}$  apart. Here, the upper and lower boundaries are set to  $T_0 = 293.15$  K, indicating that the boundary has a good cooling capacity. However, if there is heat convection, the lower boundary condition is set to heat flux, and the convective heat flux is  $q_0 = -h_{\text{htc}} \cdot \Delta T = n \cdot k \nabla \Delta T$ , and  $n$  is the direction vector of the boundary. The value of  $h_{\text{htc}}$  needs to be determined according to the actual situation.



**Fig. 6.** Schematic of a single metasurface element used for both the electromagnetic and heat transfer simulations and their associated boundary conditions.

### APPENDIX B: $|H|$ - AND $Q_{\text{abs}}$ -FIELD DISTRIBUTIONS FOR $\lambda = 6.142 \mu\text{m}$ AND $\lambda = 7.795 \mu\text{m}$

The  $|H|$ - and  $Q_{\text{abs}}$ -field distributions for  $\lambda = 6.142 \mu\text{m}$  and  $\lambda = 7.795 \mu\text{m}$  are shown in Fig. 7. The distinctly different magnetic field distributions further illustrate the different dependence of the two peaks [Figs. 7(a) and 7(b)]. While

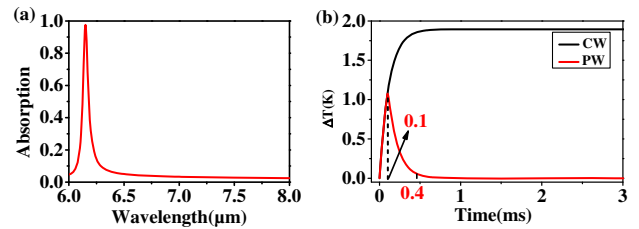


**Fig. 7.** (a), (b)  $|H|$ - and (c), (d)  $Q_{\text{abs}}$ -field distributions for  $\lambda = 6.142 \mu\text{m}$  and  $\lambda = 7.795 \mu\text{m}$ , respectively.

absorption only occurs in the metal layer, their power loss patterns are almost the same [Figs. 7(c) and 7(d)].

### APPENDIX C: OPTICAL AND THERMAL PROPERTIES OF THE STRUCTURE FOR $h = 300 \text{ nm}$

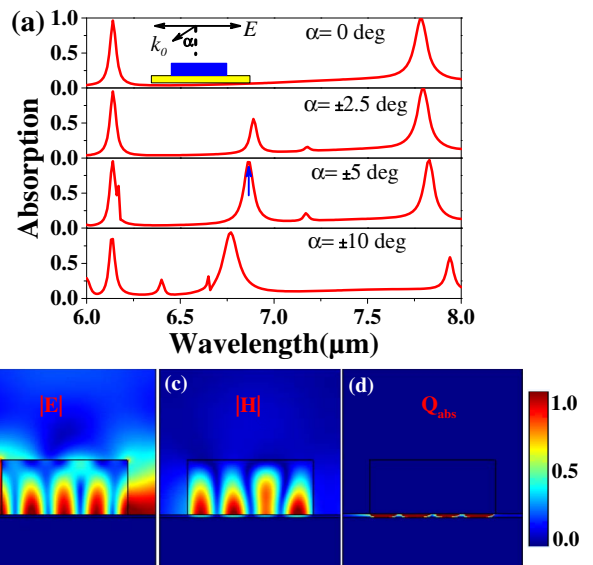
When  $h = 300 \text{ nm}$ , only one absorption peak ( $\lambda = 6.155 \mu\text{m}$ ) emerges in the absorption spectrum as shown in Fig. 8(a). Figure 8(b) shows the temporal temperature distributions under continuous wave and pulsed wave illumination with incident flux  $I_0 = 1 \text{ W/cm}^2$ .



**Fig. 8.** (a) Absorption spectrum. (b) Temporal temperature distributions under continuous wave and pulsed wave illumination with incident flux  $I_0 = 1 \text{ W/cm}^2$ . Here, pulse ( $t$ ) = 1 for  $0 < t \leq 0.1 \text{ ms}$ , and pulse( $t$ ) = 0 otherwise.  $P = 5700 \text{ nm}$ ,  $w = 4000 \text{ nm}$ .

### APPENDIX D: ABSORPTION SPECTRA FOR DIFFERENT INCIDENT ANGLE AND FIELD DISTRIBUTIONS FOR THE ADDITIONAL ABSORPTION WAVELENGTH $\lambda = 6.865 \mu\text{m}$ AT $\alpha = \pm 5 \text{ deg}$

Figure 9(a) shows the absorption spectra for different incident angle  $\alpha$ . A new absorption peak appears when  $\alpha \neq 0 \text{ deg}$ .

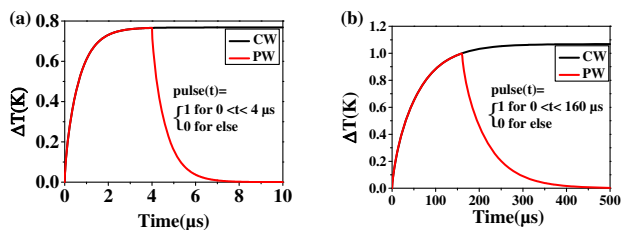


**Fig. 9.** (a) Absorption spectra for different incident angle  $\alpha$ . (b)–(d) Field distributions for  $|E|$ ,  $|H|$ , and,  $Q_{\text{abs}}$  at the additional absorption wavelength  $\lambda = 6.865 \mu\text{m}$  [denoted by blue arrow in (a)], respectively.

Figures 9(b)–9(d) show the  $|E|$ -,  $|H|$ - and  $Q_{\text{abs}}$ -field distributions for the additional absorption wavelength at  $\lambda = 6.865 \mu\text{m}$  (denoted by the blue arrow) at  $\alpha = \pm 5 \text{ deg}$ .

## APPENDIX E: TRANSIENT TEMPERATURE RESPONSE FOR DIFFERENT SUBSTRATE MATERIALS

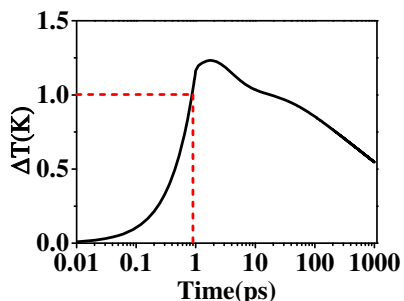
It can be seen from Fig. 10 that when Si is used as the substrate, the detector can only detect signals with a radiant power density greater than  $10^3 \text{ W/cm}^2$ , while the lowest radiant power density for the  $\text{SiO}_2$  substrate system is about  $15 \text{ W/cm}^2$ . When suspended (air), the detection limit of the radiant power density is less than  $1 \text{ W/cm}^2$  due to the smallest thermal conductivity, mass density, and specific heat capacity.



**Fig. 10.** Temporal temperature distributions under continuous wave and pulsed wave illumination for different substrate materials (a) Si with  $I_0 = 10^3 \text{ W/cm}^2$  and (b)  $\text{SiO}_2$  with  $I_0 = 15 \text{ W/cm}^2$ .

## APPENDIX F: SIMULATED TEMPORAL TEMPERATURE DISTRIBUTIONS AFTER EXCITATION WITH A FS-PULSE

Figure 11 shows the simulated temporal temperature distributions after excitation with a fs-pulse (the Si-substrate and 1 kHz, 100 fs laser at  $\lambda = 6.142 \mu\text{m}$  were used).



**Fig. 11.** Simulated temporal temperature distributions after excitation with a fs-pulse.

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<sup>†</sup>These authors contributed equally to this paper.

## REFERENCES

1. T. W. Ebbesen, H. J. Lezec, H. F. Ghaemi, T. Thio, and P. A. Wolff, "Extraordinary optical transmission through sub-wavelength hole arrays," *Nature* **391**, 667–669 (1998).
2. F. J. García-Vidal, E. Moreno, J. A. Porto, and L. Martín-Moreno, "Transmission of light through a single rectangular hole," *Phys. Rev. Lett.* **95**, 103901 (2005).
3. Z. Ruan and M. Qiu, "Enhanced transmission through periodic arrays of subwavelength holes: the role of localized waveguide resonances," *Phys. Rev. Lett.* **96**, 233901 (2006).
4. Y. Ling, L. Huang, W. Hong, T. Liu, J. Luan, W. Liu, J. Lai, and H. Li, "Polarization-controlled dynamically switchable plasmon induced transparency in plasmonic metamaterial," *Nanoscale* **10**, 19517–19523 (2018).
5. Z. Chen, F. Zhang, Q. Zhang, J. Ren, H. Hao, X. Duan, P. Zeng, T. Zhang, Y. Gu, and Q. Gong, "Blue-detuned optical atom trapping in a compact plasmonic structure," *Photon. Res.* **5**, 436–440 (2017).
6. S. Zhang, D. A. Genov, Y. Wang, M. Liu, and X. Zhang, "Plasmon-induced transparency in metamaterials," *Phys. Rev. Lett.* **101**, 047401 (2008).
7. N. I. Landy, S. Sajuyigbe, J. J. Mock, D. R. Smith, and W. J. Padilla, "Perfect metamaterial absorber," *Phys. Rev. Lett.* **100**, 207402 (2008).
8. X. Liu, T. Tyler, T. Starr, A. F. Starr, N. M. Jokerst, and W. J. Padilla, "Taming the blackbody with infrared metamaterials as selective thermal emitters," *Phys. Rev. Lett.* **107**, 045901 (2011).
9. X. C. Tong, *Functional Metamaterials and Metadevices* (Springer, 2018).
10. Y. He, K. Lawrence, W. Ingram, and Y. Zhao, "Circular dichroism based refractive index sensing using chiral metamaterials," *Chem. Commun.* **52**, 2047–2050 (2016).
11. W. Wang, F. Yan, S. Tan, H. Zhou, and Y. Hou, "Ultrasensitive terahertz metamaterial sensor based on vertical split ring resonators," *Photon. Res.* **5**, 571–577 (2017).
12. Y. Zhao and A. Alu, "Manipulating light polarization with ultrathin plasmonic metasurfaces," *Phys. Rev. B* **84**, 205428 (2011).
13. Y. Zhao, M. Belkin, and A. Alu, "Twisted optical metamaterials for planarized ultrathin broadband circular polarizers," *Nat. Commun.* **3**, 870 (2012).
14. R. Ji, S. Wang, X. Liu, X. Chen, and W. Li, "Broadband circular polarizers constructed using helix-like chiral metamaterials," *Nanoscale* **8**, 14725–14729 (2016).
15. A. K. Mikhail and C. Federico, "Optical absorbers based on strong interference in ultra-thin films," *Laser Photon. Rev.* **10**, 735–749 (2016).
16. Z. Li, S. Butun, and K. Aydin, "Large-area, lithography-free super absorbers and color filters at visible frequencies using ultrathin metallic films," *ACS Photon.* **2**, 183–188 (2015).
17. J. Zhao, X. Yu, X. Yang, C. Augustine, W. Yuan, and Y. Yu, "Polarization-independent and high-efficiency broadband optical absorber in visible light based on nanostructured germanium arrays," *Opt. Lett.* **44**, 963–966 (2019).
18. Z. Li, W. Liu, H. Cheng, D. Choi, S. Chen, and J. Tian, "Spin-selective full-dimensional manipulation of optical waves with chiral mirror," *Adv. Mater.* **32**, 1907983 (2020).
19. I. Ozbay, A. Ghobadi, B. Butun, and G. Turhan-Sayan, "Bismuth plasmonics for extraordinary light absorption in deep sub-wavelength geometries," *Opt. Lett.* **45**, 686–689 (2020).
20. X. Liu, T. Starr, A. F. Starr, and W. J. Padilla, "Infrared spatial and frequency selective metamaterial with near-unity absorbance," *Phys. Rev. Lett.* **104**, 207403 (2010).
21. C. Wu, B. Neuner, J. John, A. Milder, B. Zollars, S. Savoy, and G. Shvets, "Metamaterial-based integrated plasmonic absorber/emitter for solar thermo-photovoltaic systems," *J. Opt.* **14**, 024005 (2012).
22. K. Aydin, V. E. Ferry, R. M. Briggs, and H. A. Atwater, "Broadband polarization-independent resonant light absorption using ultrathin plasmonic super absorbers," *Nat. Commun.* **2**, 517 (2011).
23. J. B. Chou, Y. X. Yeng, Y. E. Lee, A. Lenert, V. Rinnerbauer, I. Celanovic, M. Soljačić, N. X. Fang, E. N. Wang, and S.-G. Kim,

- "Enabling ideal selective solar absorption with 2D metallic dielectric photonic crystals," *Adv. Mater.* **26**, 8041–8045 (2014).
24. Y. Zhang, D. Meng, X. Li, H. Yu, J. Lai, Z. Fan, and C. Chen, "Significantly enhanced infrared absorption of graphene photodetector under surface-plasmonic coupling and polariton interference," *Opt. Express* **26**, 30862–30872 (2018).
  25. A. Safaei, S. Chandra, M. W. Shabbir, M. N. Leuenberger, and D. Chanda, "Dirac plasmon-assisted asymmetric hot carrier generation for room-temperature infrared detection," *Nat. Commun.* **10**, 3498 (2019).
  26. T. D. Dao, S. Ishii, A. T. Doan, Y. Wada, A. Ohi, T. Nabatame, and T. Nagao, "An on-chip quad-wavelength pyroelectric sensor for spectroscopic infrared sensing," *Adv. Sci.* **6**, 1900579 (2019).
  27. Z. Taghipour, S. Lee, S. A. Myers, E. H. Steenberg, C. P. Morath, V. M. Cowan, S. Mathews, G. Balakrishnan, and S. Krishna, "Temperature-dependent minority-carrier mobility in p-type InAs/GaSb type-II-superlattice photodetectors," *Phys. Rev. Appl.* **11**, 024047 (2019).
  28. T. D. Nguyen, J. O. Kim, Y. H. Kim, E. T. Kim, Q. L. Nguyen, and S. J. Lee, "Dual-color short-wavelength infrared photodetector based on InGaAsSb/GaSb heterostructure," *AIP Adv.* **8**, 025015 (2018).
  29. S. Liu, M. Li, J. Zhang, D. Su, Z. Huang, S. Kunwar, and J. Lee, "Self-assembled Al nanostructure/ZnO quantum dot heterostructures for high responsivity and fast UV photodetector," *Nano-Micro Lett.* **12**, 114 (2020).
  30. Y. F. Xiong, J. H. Chen, Y. Q. Lu, and F. Xu, "Broadband optical-fiber-compatible photodetector based on a graphene-MoS<sub>2</sub>-WS<sub>2</sub> heterostructure with a synergetic photogenerating mechanism," *Adv. Electron. Mater.* **5**, 1800562 (2019).
  31. J. Yao and G. Yang, "2D material broadband photodetectors," *Nanoscale* **12**, 454–476 (2020).
  32. L. Ye, P. Wang, W. Luo, F. Gong, L. Liao, T. Liu, L. Tong, J. Zang, J. Xu, and W. Hu, "Highly polarization sensitive infrared photodetector based on black phosphorus-on-WSe<sub>2</sub> photogate vertical heterostructure," *Nano Energy* **37**, 53–60 (2017).
  33. M. W. Knight, H. Sobhani, P. Nordlander, and N. J. Halas, "Photodetection with active optical antennas," *Science* **332**, 702–704 (2011).
  34. W. Li and J. Valentine, "Metamaterial perfect absorber based hot electron photo detection," *Nano Lett.* **14**, 3510–3514 (2014).
  35. Y. Ho, Y. Tai, J. K. Clark, Z. Wang, P. Wei, and J. Delaunay, "Plasmonic hot-carriers in channel-coupled nanogap structure for metal-semiconductor barrier modulation and spectral-selective plasmonic monitoring," *ACS Photon.* **5**, 2617–2623 (2018).
  36. T. D. Dao, K. Chen, S. Ishii, A. Ohi, T. Nabatame, M. Kitajima, and T. Nagao, "Infrared perfect absorbers fabricated by colloidal mask etching of Al–Al<sub>2</sub>O<sub>3</sub>–Al trilayers," *ACS Photon.* **2**, 964–970 (2015).
  37. S. Kang, Z. Qian, V. Rajaram, S. D. Calisgan, A. Alu, and M. Rinaldi, "Ultra-narrowband metamaterial absorbers for high spectral resolution infrared spectroscopy," *Adv. Opt. Mater.* **7**, 1801236 (2019).
  38. J. Park, J. Kang, S. J. Kim, X. Liu, and M. L. Brongersma, "Dynamic reflection phase and polarization control in metasurfaces," *Nano Lett.* **17**, 407–413 (2017).
  39. S. Chen, Z. Chen, J. Liu, J. Cheng, Y. Zhou, L. Xiao, and K. Chen, "Ultra-narrow band mid-infrared perfect absorber based on hybrid dielectric metasurface," *Nanomaterials* **9**, 1350 (2019).
  40. G. Lan, Z. Jin, J. Nong, P. Luo, C. Guo, Z. Sang, L. Dong, and W. Wei, "Narrowband perfect absorber based on dielectric-metal metasurface for surface-enhanced infrared sensing," *Appl. Sci.* **10**, 2295 (2020).
  41. J. Hao, L. Zhou, and M. Qiu, "Nearly total absorption of light and heat generation by plasmonic metamaterials," *Phys. Rev. B* **83**, 165107 (2011).
  42. F. Callewaert, S. Chen, S. Butun, and K. Aydin, "Narrow band absorber based on a dielectric nanodisk array on silver film," *J. Opt.* **18**, 075006 (2016).
  43. D. J. Griffiths, *Introduction to Electrodynamics* (Prentice Hall, 1999).
  44. J. W. Stewart, J. H. Vella, W. Li, S. Fan, and M. H. Mikkelsen, "Ultrafast pyroelectric photodetection with on-chip spectral filters," *Nat. Mater.* **19**, 158–162 (2020).
  45. W. S. Yan, R. Zhang, X. Q. Xiu, Z. L. Xie, P. Han, R. L. Jiang, S. L. Gu, Y. Shi, and Y. D. Zheng, "Temperature dependence of the pyroelectric coefficient and the spontaneous polarization of AlN," *Appl. Phys. Lett.* **90**, 212102 (2007).
  46. K. W. Mauser, S. Kim, S. Mitrovic, D. Fleischman, R. Pala, K. C. Schwab, and H. A. Atwater, "Resonant thermoelectric nanophotonics," *Nat. Nanotechnol.* **12**, 770–775 (2017).
  47. L. Liu, X. Zhang, Z. Zhao, M. Pu, P. Gao, Y. Luo, J. Jin, C. Wang, and X. Luo, "Batch fabrication of metasurface holograms enabled by plasmonic cavity lithography," *Adv. Opt. Mater.* **5**, 1700429 (2017).